

Notice of References Cited	Application/Control No. 09/734,950	Applicant(s)/Patent Under Reexamination MAK ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,377,716	04-2002	Veldhuis et al.	385/1
	B	US-6,306,563	10-2001	Xu et al.	430/321
	C	US-5,408,569	04-1995	Nishimoto, Hiroshi	385/132
	D	US-5,396,351	03-1995	Gessel, David J.	349/159
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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